MSCSM120HM16CT3AG Datasheet Full Bridge SiC MOSFET Power Module

January 2020





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1 Revision History

The revision history describes the changes that were implemented in the document. The changes are listed by revision, starting with the most current publication.

1.1 Revision 1.0

Revision 1.0 was published in January 2020. It is the first publication of this document.



2 Product Overview

This MSCSM120HM16CT3AG device is a full bridge 1200 V/173 A full Silicon Carbide (SiC) power module.

Figure 1 • MSCSM120HM16CT3AG Electrical Schematic

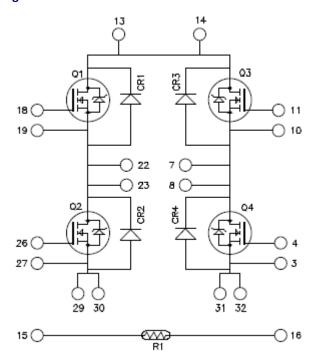
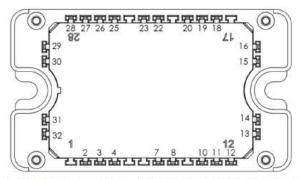


Figure 2 • MSCSM120HM16CT3AG Pinout Location



All multiple inputs & outputs must be shorted together Example: 13/14; 29/30; 22/23...

All ratings at $T_1 = 25$ °C, unless otherwise specified.

Caution: These devices are sensitive to electrostatic discharge. Proper handling procedures should be followed.



2.1 Features

The following are key features of the MSCSM120HM16CT3AG device:

- SiC Power MOSFET
 - Low R_{DS(on)}
 - High temperature performance
- · SiC Schottky Diode
 - Zero reverse recovery
 - Zero forward recovery
 - Temperature independent switching behavior
 - Positive temperature coefficient on VF
- Very low stray inductance
- · Internal thermistor for temperature monitoring
- Aluminum nitride (AIN) substrate for improved thermal performance

2.2 Benefits

The following are benefits of the MSCSM120HM16CT3AG device:

- High power and efficiency converters and inverters
- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction-to-case thermal resistance
- · Solderable terminals for power and signal, for easy PCB mounting
- · Low profile
- · RoHS compliant

2.3 Applications

The MSCSM120HM16CT3AG device is designed for the following applications:

- Uninterruptible power supplies
- Switched mode power supplies
- EV motor and traction drive
- Welding converters



3 Electrical Specifications

This section shows the electrical specifications of the MSCSM120HM16CT3AG device.

3.1 SiC MOSFET Characteristics (Per MOSFET)

The following table lists the absolute maximum ratings per MOSFET of the MSCSM120HM16CT3AG device.

Table 1 • Absolute Maximum Ratings

Symbol	Parameter			Unit
V _{DSS}	Drain-source voltage			V
I _D	Continuous drain current T _C = 25 °C			А
	T _C = 80 °C		138 ¹	
I _{DM}	Pulsed drain current			
V _{GS}	Gate-source voltage			V
R _{DSon}	Drain-source ON resistance			mΩ
P _D	Power dissipation	T _C = 25 °C	745	w

Note:

1. Specification of SiC MOSFET device, but output current must be limited due to size of power connectors.

The following table lists the electrical characteristics per MOSFET of the MSCSM120HM16CT3AG device.

Table 2 • Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I _{DSS}	Zero gate voltage drain current	V _{GS} = 0 V; V _{DS} = 1200 V			20	200	μΑ
R _{DS(on)}	Drain-source on resistance	I _D = 80 A	T _J = 25 °C		12.5	16	mΩ
			T _J = 175 °C		20		
V _{GS(th)}	Gate threshold voltage	$V_{GS} = V_{DS}$, $I_D = 2 \text{ mA}$		1.8	2.8		V
I _{GSS}	Gate-source leakage current	V _{GS} = 20 V, V _{DS} = 0 V				200	nA



The following table lists the dynamic characteristics per MOSFET of the MSCSM120HM16CT3AG device.

Table 3 • Dynamic Characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
C _{iss}	Input capacitance	V _{GS} = 0 V			6040		pF
C _{oss}	Output capacitance	V _{DS} = 1000 V f = 1 MHz			540		
C _{rss}	Reverse transfer capacitance	-			50		
Q _g	Total gate charge	V _{GS} = -5 V/20 V			464		nC
Q_{gs}	Gate-source charge	V _{Bus} = 800 V I _D = 80 A			82		
Q _{gd}	Gate-drain charge				100		
T _{d(on)}	Turn-on delay time	V _{GS} = -5 V/20 V			30		ns
T _r	Rise time	V _{Bus} = 600 V I _D = 100 A			30		
T _{d(off)}	Turn-off delay time	$R_{Gon} = 4 \Omega$; $R_{Goff} = 2.4 \Omega$			50		
T _f	Fall time				25		
E _{on}	Turn on energy	Inductive switching	T _J = 150 °C		1.98		mJ
E _{off}	Turn off energy	$V_{GS} = -5 \text{ V}/20 \text{ V}$ $V_{Bus} = 600 \text{ V}$ $I_D = 100 \text{ A}$ $R_{Gon} = 4 \Omega$ $R_{Goff} = 2.4 \Omega$			1.3		mJ
R _{Gint}	Internal gate resistance				2.94		Ω
R _{thJC}	Junction-to-case thermal resistance					0.2	°C/W

The following table lists the body diode ratings and characteristics per MOSFET of the MSCSM120HM16CT3AG device.

Table 4 • Body Diode Ratings and Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
V _{SD}	Diode forward voltage	V _{GS} = 0 V; I _{SD} = 80 A V _{GS} = -5 V; I _{SD} = 80 A		4.0		V
				4.2		
t _{rr}	Reverse recovery time	I _{SD} = 80 A; V _{GS} = -5 V		90		ns
Q _{rr}	Reverse recovery charge	$V_R = 800 \text{ V; } d_{iF}/dt = 2000 \text{ A}/\mu\text{s}$		1100		nC
I _{rr}	Reverse recovery current			27		Α



3.2 Reverse SiC Diode Ratings and Characteristics (Per SiC Diode)

The following table lists the reverse SiC diode ratings and characteristics per SiC diode of the MSCSM120HM16CT3AG device.

Table 5 • Reverse SiC Diode Ratings and Characteristics (per SiC diode)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V _{RRM}	Peak repetitive reverse voltage					1200	V
I _{RM}	Reverse leakage current	V _R = 1200 V	T _J = 25 °C		20	400	μΑ
			T _J = 175 °C		300		
I _F	DC forward current		T _C = 100 °C		60		А
V _F	Diode forward voltage	I _F = 60 A	T _J = 25 °C		1.5	1.8	V
			T _J = 175 °C		2.1		
Qc	Total capacitive charge	V _R = 600 V			260		nC
С	Total capacitance	f = 1 MHz, V _R = 400 V			282		pF
		f = 1 MHz, V _R = 800 V			210		
R _{thJC}	Junction-to-case thermal resistance	e				0.477	°C/W

3.3 Thermal and Package Characteristics

The following table lists the package characteristics of the MSCSM120HM16CT3AG device.

Table 6 • Package Characteristics

Symbol	Characteristic				Max	Unit
V _{ISOL}	RMS isolation voltage, any terminal to case t = 1 min, 50 Hz/60 Hz					V
Тј	Operating junction temperature range			-40	175	°C
T _{JOP}	Recommended junction temperature under switching conditions			-40	T _{Jmax} -25	
T _{STG}	Storage temperature range			-40	125	
T _C	Operating case temperature			-40	125	
Torque	Mounting torque To heatsink M4				3	N.m
Wt	Package weight				110	g



The following table lists the temperature sensor NTC (see application note *APT0406* on www.microsemi.com) of the MSCSM120HM16CT3AG device.

Table 7 • Temperature Sensor NTC

Symbol	Characteristic I		Min	Тур	Max	Unit
R ₂₅	Resistance at 25 °C			50		kΩ
$\Delta R_{25}/R_{25}$				5		%
B _{25/85}	T ₂₅ = 298.15 K			3952		К
ΔΒ/Β		T _C = 100 °C		4		%

$$R_T = \frac{R_{25}}{\exp \left[B_{25/85} \left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]} \quad \text{T: Thermistor temperature } \\ R_T: \text{ Thermistor value at T}$$



3.4 Typical SiC MOSFET Performance Curves

This sections shows the typical SiC MOSFET performance curves of the MSCSM120HM16CT3AG device.

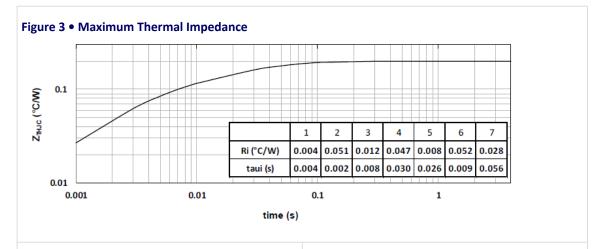
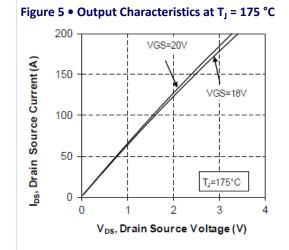
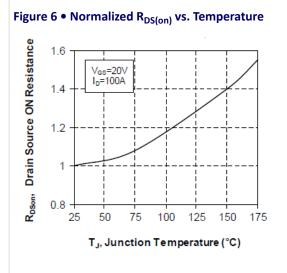


Figure 4 • Output Characteristics at T_J = 25 °C 200 Drain Source Current(A) 150 V_{GS}=20V VGS=18V 100 50 T_J=25°C 0 0.5 2.5 0.0 1.0 1.5 2.0 V_{DS}, Drain Source Voltage (V)





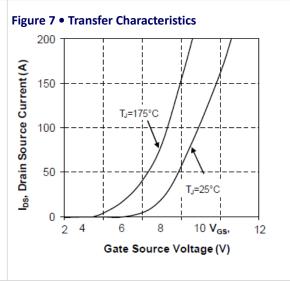
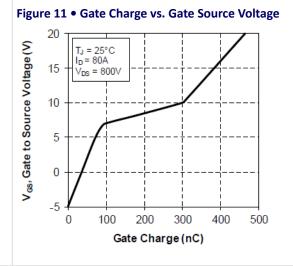


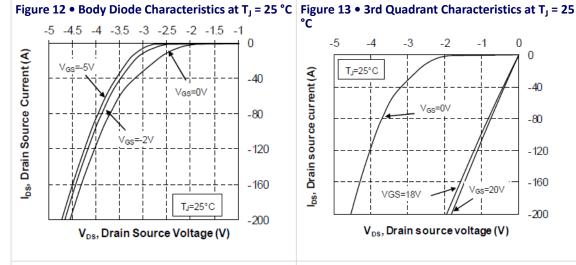


Figure 8 • Switching Energy vs. Rg 2.50 Eon 2.25 2.00 Losses (mJ) 1.75 Foff 1.50 V_{GS}=5/20V I_D= 100A 1.25 V_{BUS} = 600V T_J = 150°C 1.00 5 8 9 Gate Resistance (Ω)

Figure 9 • Switching energy vs Current V_{GS}=5/20V R_{Gon}=4Ω Eon R_{coff}=2.4Ω V_{BUS}= 600∨ Losses (mJ) T. = 150°C Eoff 0 50 100 150 200 Current (A)

Figure 10 • Capacitance vs. Drain Source Voltage 100000 C, Capacitance (pF) 10000 Ciss 1000 Coss 100 Crss 10 0 200 400 600 800 1000 V_{DS}, Drain Source Voltage (V)





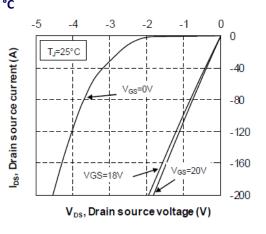
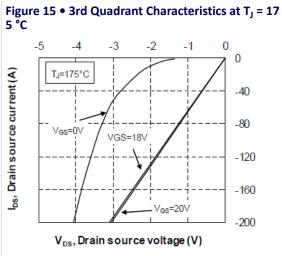
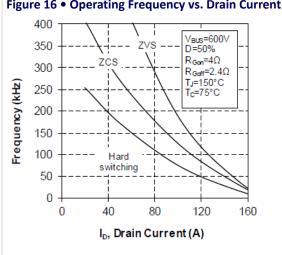




Figure 14 • Body Diode Characteristics at T₁ = 175 °cັ -4 -3.5 -3 -2.5 -2 0 los, Drain source current (A) V_{GS}=-5V -40 -80 V_{GS}=0V -120 -160 T_J=175°C -200 V_{DS}, Drain source voltage (V) Figure 16 • Operating Frequency vs. Drain Current 400







3.5 Typical SiC Diode Performance Curves

This sections shows the typical SiC diode performance curves of the MSCSM120HM16CT3AG device.

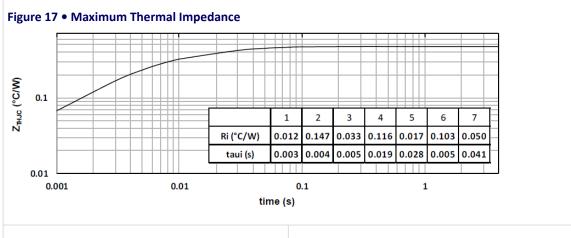
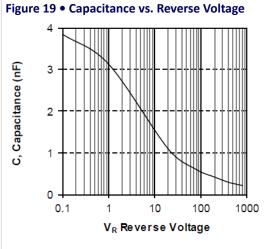


Figure 18 • Forward Characteristics 120 IF. Forward Current (A) 100 80 60 TJ=175°C 40 20 0 0 0.5 1.5 2 2.5 3.5 V_{F.} Forward Voltage (V)





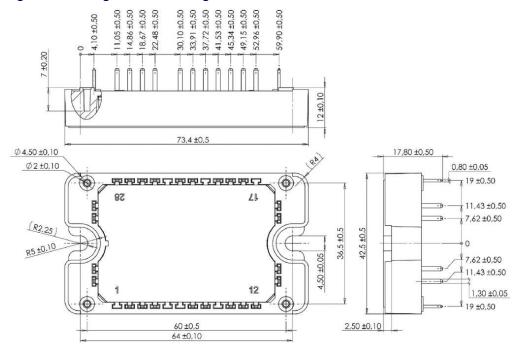
4 Package Specifications

This section shows the package specifications of the MSCSM120HM16CT3AG device.

4.1 Package Outline Drawing

The following figure illustrates the package outline of the MSCSM120HM16CT3AG device. The dimensions are in millimeters.

Figure 20 • Package Outline Drawing



Note: See application note *1906—Mounting Instructions for SP3F Power Modules* on www.microsemi.com





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